

# BFU760F

NPN wideband silicon germanium RF transistor

Rev. 0.7 — 5 November 2010

Objective data sheet

## 1. Product profile

### 1.1 General description

NPN silicon germanium microwave transistor for high speed, low noise applications in a plastic, 4-pin dual-emitter SOT343F package.

#### CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the *ANSI/ESD S20.20*, *IEC/ST 61340-5*, *JESD625-A* or equivalent standards.

### 1.2 Features and benefits

- Low noise high linearity RF transistor
- High maximum output third-order intercept point 32 dBm at 1.8 GHz
- 110 GHz  $f_T$  silicon germanium technology

### 1.3 Applications

- Ka band oscillators DRO's
- High linearity applications
- Medium output power applications
- Wi-Fi / WLAN / WiMAX
- GPS
- ZigBee
- SDARS first stage LNA
- LTE, cellular, UMTS

## 1.4 Quick reference data

Table 1. Quick reference data

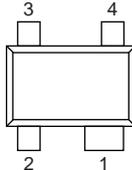
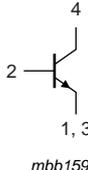
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{CBO}$	collector-base voltage	open emitter	-	-	10	V
$V_{CEO}$	collector-emitter voltage	open base	-	-	2.8	V
$V_{EBO}$	emitter-base voltage	open collector	-	-	1.0	V
$I_C$	collector current		-	25	70	mA
$P_{tot}$	total power dissipation	$T_{sp} \leq 90\text{ }^\circ\text{C}$	[1]	-	220	mW
$h_{FE}$	DC current gain	$I_C = 10\text{ mA}$ ; $V_{CE} = 2\text{ V}$ ; $T_j = 25\text{ }^\circ\text{C}$	155	330	505	
$C_{CBS}$	collector-base capacitance	$V_{CB} = 2\text{ V}$ ; $f = 1\text{ MHz}$	-	175	-	fF
$f_T$	transition frequency	$I_C = 50\text{ mA}$ ; $V_{CE} = 1\text{ V}$ ; $f = 2\text{ GHz}$ ; $T_{amb} = 25\text{ }^\circ\text{C}$	-	45	-	GHz
$G_{p(max)}$	maximum power gain	$I_C = 50\text{ mA}$ ; $V_{CE} = 1\text{ V}$ ; $f = 2.4\text{ GHz}$ ; $T_{amb} = 25\text{ }^\circ\text{C}$	[2]	22	-	dB
NF	noise figure	$I_C = 12\text{ mA}$ ; $V_{CE} = 2\text{ V}$ ; $f = 2.4\text{ GHz}$ ; $\Gamma_S = \Gamma_{opt}$	-	0.50	-	dB
IP3	third-order intercept point	$I_C = 30\text{ mA}$ ; $V_{CE} = 2.5\text{ V}$ ; $Z_S = Z_L = 50\ \Omega$ ; $f = 2.4\text{ GHz}$ ; $T_{amb} = 25\text{ }^\circ\text{C}$	-	32	-	dBm

[1]  $T_{sp}$  is the temperature at the solder point of the emitter lead.

[2]  $G_{p(max)}$  is the maximum power gain, if  $K > 1$ . If  $K < 1$  then  $G_{p(max)}$  = Maximum Stable Gain (MSG).

## 2. Pinning information

Table 2. Discrete pinning

Pin	Description	Simplified outline	Graphic symbol
1	emitter		
2	base		
3	emitter		
4	collector		

## 3. Ordering information

Table 3. Ordering information

Type number	Package		Version
	Name	Description	
BFU760F	-	plastic surface-mounted flat pack package; reverse pinning; 4 leads	SOT343F

## 4. Marking

**Table 4. Marking**

Type number	Marking	Description
BFU760F	D7*	* = p : made in Hong Kong * = t : made in Malaysia * = w : made in China

## 5. Limiting values

**Table 5. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

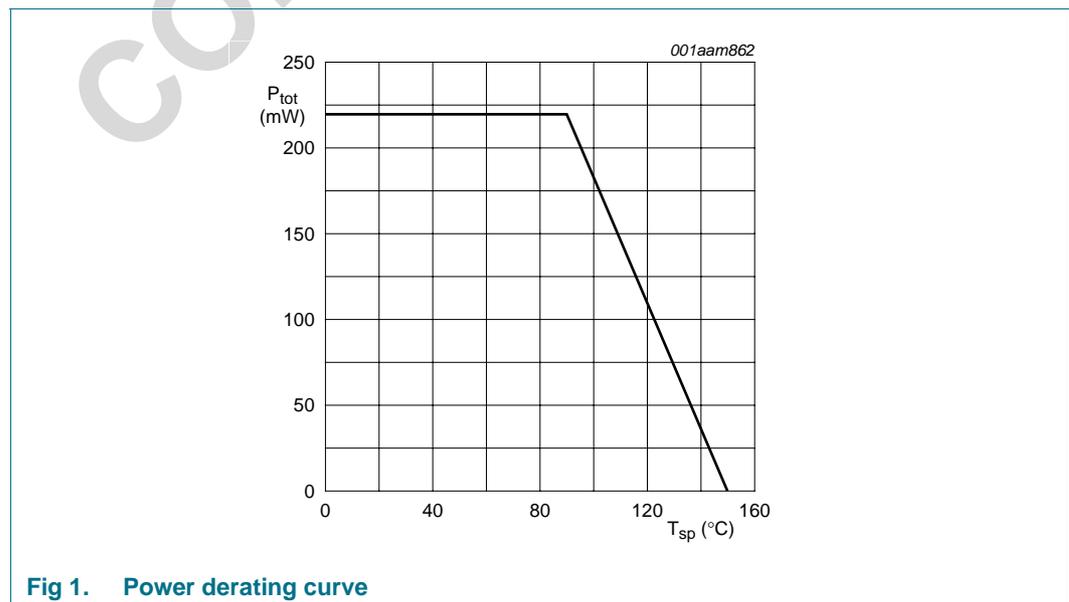
Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CBO}$	collector-base voltage	open emitter	-	10	V
$V_{CEO}$	collector-emitter voltage	open base	-	2.8	V
$V_{EBO}$	emitter-base voltage	open collector	-	1.0	V
$I_C$	collector current		-	70	mA
$P_{tot}$	total power dissipation	$T_{sp} \leq 90\text{ }^\circ\text{C}$ [1]	-	220	mW
$T_{stg}$	storage temperature		-65	+150	$^\circ\text{C}$
$T_j$	junction temperature		-	150	$^\circ\text{C}$

[1]  $T_{sp}$  is the temperature at the solder point of the emitter lead.

## 6. Thermal characteristics

**Table 6. Thermal characteristics**

Symbol	Parameter	Conditions	Typ	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point		270	K/W



**Fig 1. Power derating curve**

## 7. Characteristics

**Table 7. Characteristics**
 $T_j = 25\text{ °C}$  unless otherwise specified

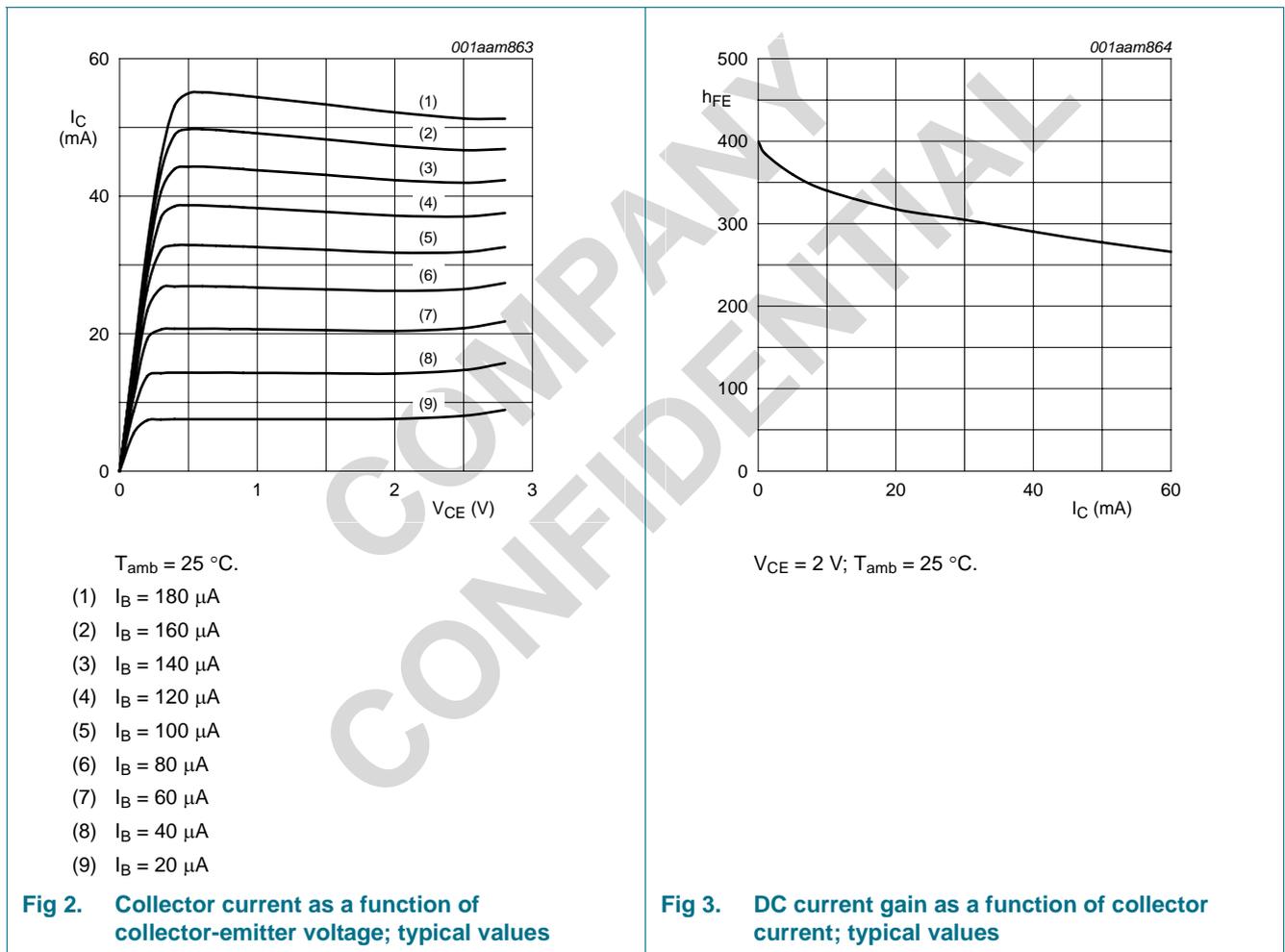
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{(BR)CBO}$	collector-base breakdown voltage	$I_C = 2.5\ \mu\text{A}; I_E = 0\ \text{mA}$	10	-	-	V
$V_{(BR)CEO}$	collector-emitter breakdown voltage	$I_C = 1\ \text{mA}; I_B = 0\ \text{mA}$	2.8	-	-	V
$I_C$	collector current		-	25	70	mA
$I_{CBO}$	collector-base cut-off current	$I_E = 0\ \text{mA}; V_{CB} = 4.5\ \text{V}$	-	-	100	nA
$h_{FE}$	DC current gain	$I_C = 10\ \text{mA}; V_{CE} = 2\ \text{V}$	155	330	505	
$C_{CES}$	collector-emitter capacitance	$V_{CB} = 2\ \text{V}; f = 1\ \text{MHz}$	-	292	-	fF
$C_{EBS}$	emitter-base capacitance	$V_{EB} = 0.5\ \text{V}; f = 1\ \text{MHz}$	-	1054	-	fF
$C_{CBS}$	collector-base capacitance	$V_{CB} = 2\ \text{V}; f = 1\ \text{MHz}$	-	175	-	fF
$f_T$	transition frequency	$I_C = 50\ \text{mA}; V_{CE} = 1\ \text{V}; f = 2\ \text{GHz}; T_{amb} = 25\text{ °C}$	-	45	-	GHz
$G_{p(max)}$	maximum power gain	$I_C = 50\ \text{mA}; V_{CE} = 1\ \text{V}; T_{amb} = 25\text{ °C}$				
		$f = 1.5\ \text{GHz}$	-	25.5	-	dB
		$f = 1.8\ \text{GHz}$	-	24	-	dB
		$f = 2.4\ \text{GHz}$	-	22	-	dB
		$f = 5.8\ \text{GHz}$	-	13.5	-	dB
$ S_{21} ^2$	insertion power gain	$I_C = 50\ \text{mA}; V_{CE} = 1\ \text{V}; T_{amb} = 25\text{ °C}$				
		$f = 1.5\ \text{GHz}$	-	22	-	dB
		$f = 1.8\ \text{GHz}$	-	20.5	-	dB
		$f = 2.4\ \text{GHz}$	-	18	-	dB
		$f = 5.8\ \text{GHz}$	-	10.5	-	dB
NF	noise figure	$I_C = 12\ \text{mA}; V_{CE} = 2\ \text{V}; \Gamma_S = \Gamma_{opt}; T_{amb} = 25\text{ °C}$				
		$f = 1.5\ \text{GHz}$	-	0.40	-	dB
		$f = 1.8\ \text{GHz}$	-	0.45	-	dB
		$f = 2.4\ \text{GHz}$	-	0.50	-	dB
		$f = 5.8\ \text{GHz}$	-	0.75	-	dB
$G_{ass}$	associated gain	$I_C = 12\ \text{mA}; V_{CE} = 2\ \text{V}; \Gamma_S = \Gamma_{opt}; T_{amb} = 25\text{ °C}$				
		$f = 1.5\ \text{GHz}$	-	23	-	dB
		$f = 1.8\ \text{GHz}$	-	21.5	-	dB
		$f = 2.4\ \text{GHz}$	-	19.5	-	dB
		$f = 5.8\ \text{GHz}$	-	12.5	-	dB
$P_{L(1dB)}$	output power at 1 dB gain compression	$I_C = 30\ \text{mA}; V_{CE} = 2.5\ \text{V}; Z_S = Z_L = 50\ \Omega; T_{amb} = 25\text{ °C}$				
		$f = 1.5\ \text{GHz}$	-	18	-	dBm
		$f = 1.8\ \text{GHz}$	-	18	-	dBm
		$f = 2.4\ \text{GHz}$	-	17	-	dBm
		$f = 5.8\ \text{GHz}$	-	18.5	-	dBm

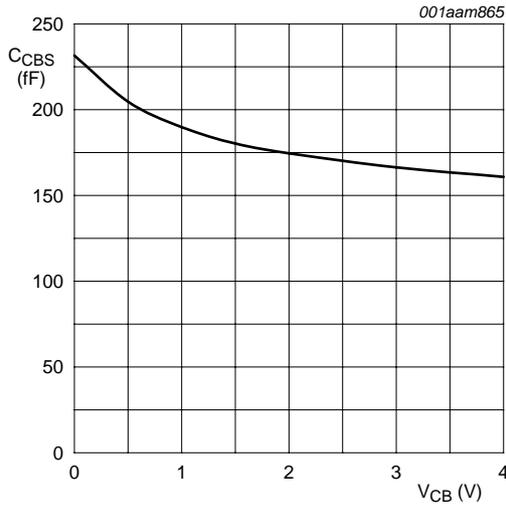
**Table 7. Characteristics ...continued**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
IP3	third-order intercept point	$I_C = 30\text{ mA}; V_{CE} = 2.5\text{ V};$ $Z_S = Z_L = 50\text{ }\Omega; T_{amb} = 25\text{ }^\circ\text{C}$				
		$f = 1.5\text{ GHz}$	-	32	-	dBm
		$f = 1.8\text{ GHz}$	-	32	-	dBm
		$f = 2.4\text{ GHz}$	-	32	-	dBm
		$f = 5.8\text{ GHz}$	-	33	-	dBm

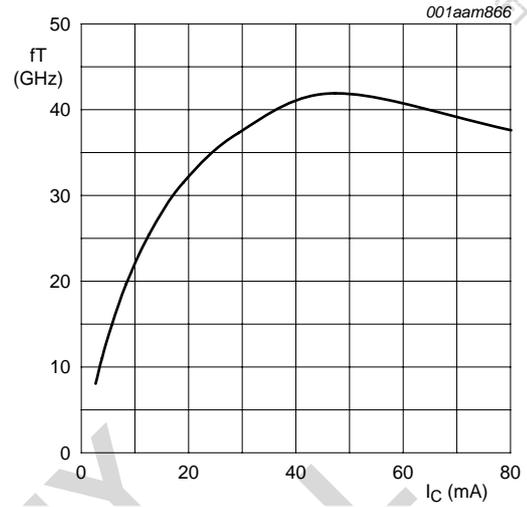
[1]  $G_{p(max)}$  is the maximum power gain, if  $K > 1$ . If  $K < 1$  then  $G_{p(max)} = MSG$ .





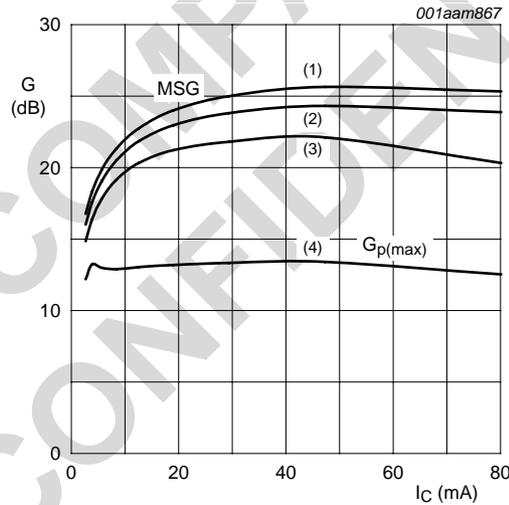
$f = 1 \text{ MHz}$ ,  $T_{amb} = 25 \text{ }^\circ\text{C}$ .

**Fig 4. Collector-base capacitance as a function of collector-base voltage; typical values**



$V_{CE} = 1 \text{ V}$ ;  $f = 2 \text{ GHz}$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$ .

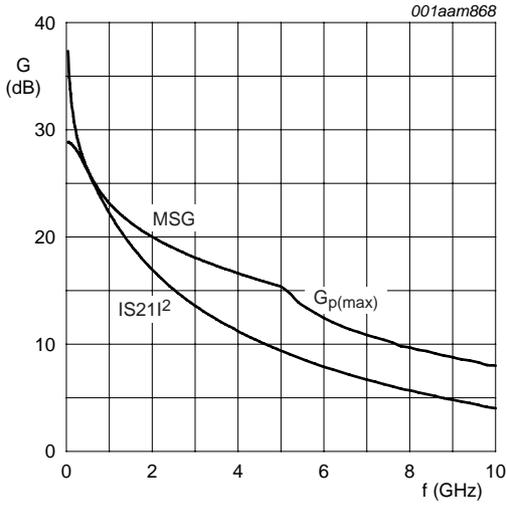
**Fig 5. Transition frequency as a function of collector current; typical values**



$V_{CE} = 1 \text{ V}$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$ .

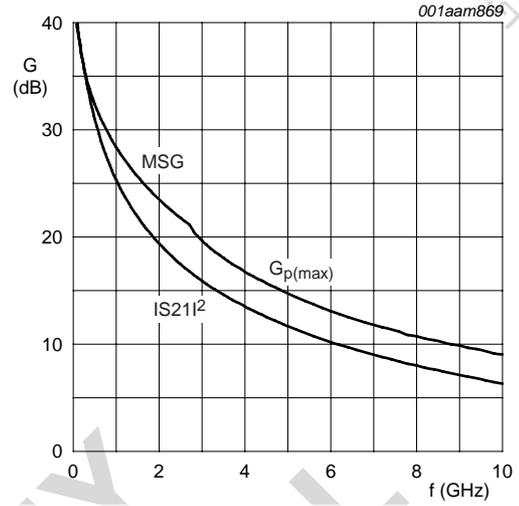
- (1)  $f = 1.5 \text{ GHz}$
- (2)  $f = 1.8 \text{ GHz}$
- (3)  $f = 2.4 \text{ GHz}$
- (4)  $f = 5.8 \text{ GHz}$

**Fig 6. Gain as a function of collector current; typical value**



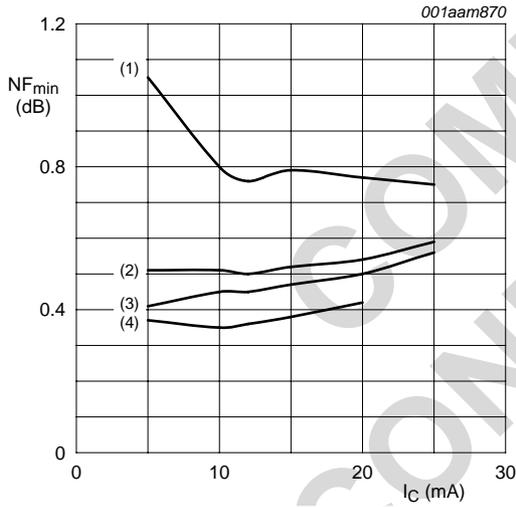
$V_{CE} = 1\text{ V}; I_C = 8\text{ mA}; T_{amb} = 25\text{ }^\circ\text{C}.$

**Fig 7. Gain as a function of frequency; typical values**



$V_{CE} = 1\text{ V}; I_C = 50\text{ mA}; T_{amb} = 25\text{ }^\circ\text{C}.$

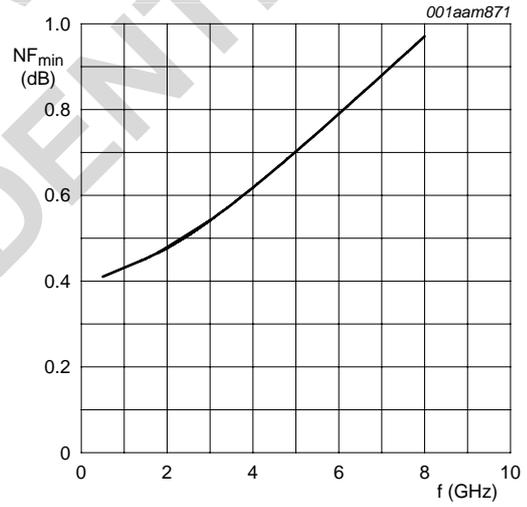
**Fig 8. Gain as a function of frequency; typical values**



$V_{CE} = 2\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}.$

- (1)  $f = 5.8\text{ GHz}$
- (2)  $f = 2.4\text{ GHz}$
- (3)  $f = 1.8\text{ GHz}$
- (4)  $f = 1.5\text{ GHz}$

**Fig 9. Minimum noise figure as a function of collector current; typical values**



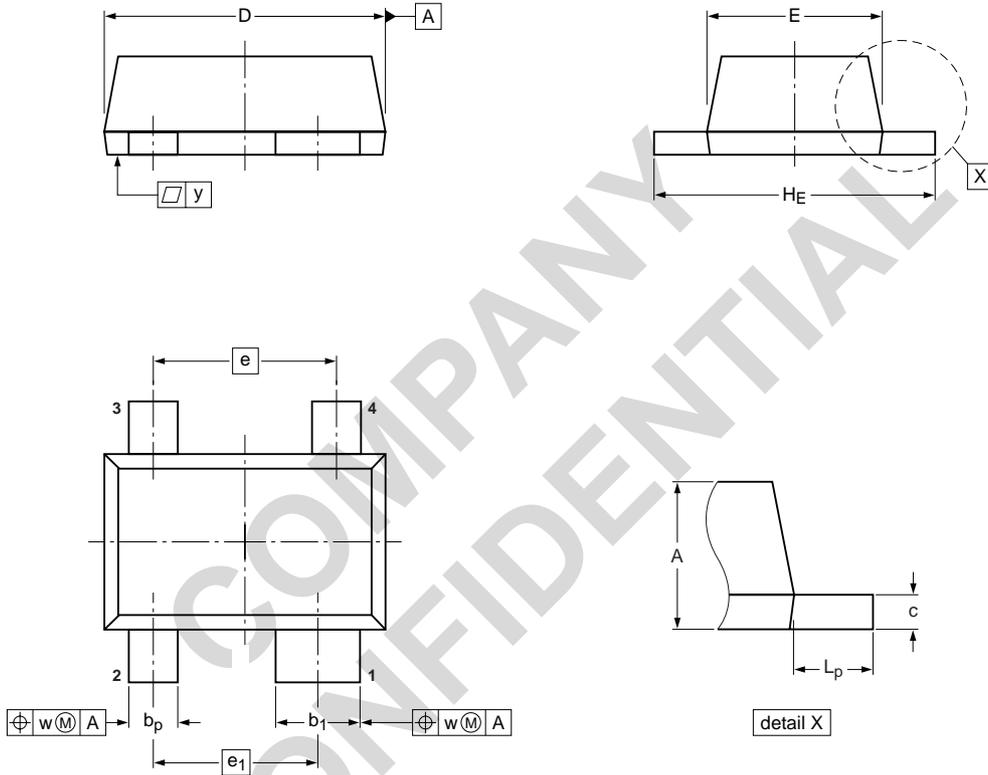
$I_C = 12\text{ mA}; V_{CE} = 2\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}.$

**Fig 10. Minimum noise figure as a function of frequency; typical values**

8. Package outline

Plastic surface-mounted flat pack package; reverse pinning; 4 leads

SOT343F



DIMENSIONS (mm are the original dimensions)

UNIT	A <sub>max</sub>	b <sub>p</sub>	b <sub>1</sub>	c	D	E	e	e <sub>1</sub>	H <sub>E</sub>	L <sub>p</sub>	w	y
mm	0.75 0.65	0.4 0.3	0.7 0.5	0.25 0.10	2.2 1.8	1.35 1.15	1.3	1.15	2.2 2.0	0.48 0.38	0.2	0.1

OUTLINE VERSION	REFERENCES			EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA		
SOT343F					05-07-12 06-03-16

Fig 11. Package outline SOT343F

## 9. Abbreviations

**Table 8. Abbreviations**

Acronym	Description
DBS	Direct Broadcast Satellite
DC	Direct Current
DRO	Dielectric Resonator Oscillator
GPS	Global Positioning System
Ka	Kurtz above
LNA	Low Noise Amplifier
LNB	Low Noise Block
LTE	Long Term Evolution
NPN	Negative-Positive-Negative
RF	Radio Frequency
SDARS	Satellite Digital Audio Radio Service
UMTS	Univeral Mobile Telecommunications System
WiMAX	Worldwide Interoperability for Microwave Access
WLAN	Wireless Local Area Network

## 10. Revision history

**Table 9. Revision history**

Document ID	Release date	Data sheet status	Change notice	Supersedes
BFU760F v.1	<tbd>	Objective data sheet	-	-

## 11. Legal information

### 11.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

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